## Application/Control No. 10/054,520 Applicant(s)/Patent Under Reexamination CHO ET AL. Examiner Hoai V Pham Applicant(s)/Patent Under Reexamination CHO ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,436,763	08-2002	Huang et al.	438/255
	В	US-2001/0054730	12-2001	Kim et al.	257/301
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	х						

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